

ATTORNEY DOCKET NO: 71661

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : SUBAGYO et al.
PCT No. : PCT/CA03/01053
For : METHOD FOR...
Dated : January 11, 2005

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Please consider the attached English language references which have come to Applicant's attention from the International Search Report. A copy of the International Search Report is also attached.

- FR 2 710 154 has been cited under Category A with the whole document indicated to be relevant. The reference discloses a method for analysis and quantification of perlite bans in ferrite-perlite steels. No full translation of this reference is available to Applicant at this time. However, an English language abstract is attached.

Respectfully submitted
for Applicant,

By:



John James McGlew
Registration No. 31,903

McGLEW AND TUTTLE, P.C.

JJM:tf
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DT15 C'd PCT/PTO 11 JAN 2005

Enclosed: PTO-1449 Form
copy of International Search Report
copies of (3) References

DATED: January 11, 2005
SCARBOROUGH STATION
SCARBOROUGH, NEW YORK 10510-0827
(914) 941-5600

SHOULD ANY OTHER FEE BE REQUIRED, THE PATENT AND TRADEMARK OFFICE
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BY: Jonathan Conte DATE: January 11, 2005

Form PTO-1449

U.S. Department of Commerce Sheet 1 of 1
Patent and Trademark OfficeLIST OF REFERENCES CITED
BY APPLICANT
(Use several sheets if necessary)Atty Docket No.: 71661
PCT No.: PCT/CA03/01053
Applicant: SUBAGYO et al.

U.S. PATENT DOCUMENTS

| Ex- aminer Initial | Document No. | Date | Name | Class | Sub- class | Filing Date |
|--------------------------|--------------|------|------|-------|---------------|-------------|
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| | <u>4,749,171</u> | <u>June 7, 1988</u> | <u>Arima et al.</u> | | | <u>June 12, 1987</u> |
| | <u>6,197,086</u> | <u>March 6, 2001</u> | <u>Stofanak et al.</u> | | | <u>Oct. 8, 1999</u> |
| | <u>6,562,285</u> | <u>May 13, 2003</u> | <u>Demysh</u> | | | <u>Nov. 15, 2000</u> |
| | | | | | | |

FOREIGN PATENT DOCUMENTS

| Ex- aminer Initial | Document No. | Date | Country | Class | Sub- class | Translation Yes/No |
|--------------------------|--------------|------|---------|-------|---------------|-----------------------|
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|--|---------------------|-----------------------|---------------|--|--|------------|
| | <u>CA 2 359 697</u> | <u>May 15, 2002</u> | <u>Canada</u> | | | <u>Yes</u> |
| | <u>FR 2 710 154</u> | <u>March 24, 1995</u> | <u>France</u> | | | <u>No</u> |
| | | | | | | |

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

| Ex- aminer Initial | Author | Date | Title | Textbook in | Translation Yes/No |
|--------------------------|--------|------|-------|-------------|-----------------------|
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|--|-----------------------------|-------------|--|---|------------|
| | <u>M. H. Bharati et al.</u> | <u>1998</u> | <u>Multivariate Image Analysis for Real- Time Process Monitoring and Control</u> | <u>Ind. Eng. Chem. Res. 1998, 37, 4715-4724</u> | <u>Yes</u> |
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Examiner

Date Considered